



SAMSUNG ELECTRONICS AMERICA, INC. American QA Lab
19 Chapin Rd. Building D
Pine Brook, NJ 07058

Date : 2020. 10. 12

UL Verification Services Inc.(formerly UL CCS)
47173 Benicia Street, Fremont, CA 94538

SUBJECT : Samsung Electronics Co., Ltd.
FCC ID : A3LSMM315F
Class II Permissive Change
Orig. Grant Date : February 7, 2020(FCC)

This is to request a Class II permissive change for FCC ID: A3LSMM315F.

This C2PC is to add the derivative model SM-F415F/DS.
The following is the changes from the original filing:

1. H/W
 - AP/CP, PMIC, BT/WIFI, Layout, A/W are same.
 - In SM-F415F/DS, only 5M macro camera connector and camera module are not mounted against Basic.
 - Memory capacity changed from 6GB to 4GB.(pin to pin)
 - All other H/W parts are the same. Additional information is provided in the operational description exhibit.

2. S/W
 - SW was updated to reflect the HW changes.
 - other than the above, all SW is same.
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3. Mechanical
 - Only color changes without changing the material of the instrument
 - Changing Camera Window Design

SM-F415F/DS was verified against the worst case raised on SM-M315F/DS for radiated emission and SAR tests only.

If you have any questions regarding this application, please feel free to contact me.

Sincerely,

A handwritten signature in black ink, appearing to read "Jenni Chun".

Jenni Chun, General Manager Regulatory & Environmental Affairs
Samsung Electronics America, Inc